Notice of References Cited

Application/Control No.

10/038,388

Examiner

Alonzo Chambliss

Applicant(s)/Patent Under
Reexamination
YU ET AL.

Art Unit
Page 1 of 2

U.S. PATENT DOCUMENTS

	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
А	US-6,426,821	07-2002	Price et al.	359/156
В	US-6,492,198	12-2002	Hwang, Chan Seung	438/108
С	US-6,372,545	04-2002	Fan et al.	438/108
D	US-5,946,590	08,1999	Satoh, Tetsuo	438/613
E	US-6,489,229	12-2002	Sheridan et al.	438/614
F	US-6,077,726	06-2000	Mistry et al.	438/108
G	US-5,943,597	08-1999	Kleffner et al.	438/613
Н	US-6,197,613	03-2001	Kung et al.	438/106
ı	US-2002/0076913	06-2002	LEE, JOO-HERN	438/614
J	US-2002/0111009	08-2002	Huang et al.	438/613
К	US-4,827,326	05-1989	Altman et al.	257/759
L	US-			2011100
М	US-			
	B C D E F G H I J K L	Country Code-Number-Kind Code A US-6,426,821 B US-6,492,198 C US-6,372,545 D US-5,946,590 E US-6,489,229 F US-6,077,726 G US-5,943,597 H US-6,197,613 I US-2002/0076913 J US-2002/0111009 K US-4,827,326 L US-	Country Code-Number-Kind Code MM-YYYY A US-6,426,821 07-2002 B US-6,492,198 12-2002 C US-6,372,545 04-2002 D US-5,946,590 08-1999 E US-6,489,229 12-2002 F US-6,077,726 06-2000 G US-5,943,597 08-1999 H US-6,197,613 03-2001 I US-2002/0076913 06-2002 J US-2002/0111009 08-2002 K US-4,827,326 05-1989 L US-	Country Code-Number-Kind Code MM-YYYY Name A US-6,426,821 07-2002 Price et al. B US-6,492,198 12-2002 Hwang, Chan Seung C US-6,372,545 04-2002 Fan et al. D US-5,946,590 08-1999 Satoh, Tetsuo E US-6,489,229 12-2002 Sheridan et al. F US-6,077,726 06-2000 Mistry et al. G US-5,943,597 08-1999 Kleffner et al. H US-6,197,613 03-2001 Kung et al. I US-2002/0076913 06-2002 LEE, JOO-HERN J US-2002/0111009 08-2002 Huang et al. K US-4,827,326 05-1989 Altman et al. L US-

FOREIGN PATENT DOCUMENTS

		T 5		- CILLION I AILINI L	- O O O MILITO	
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 63314852 A	12-1988	Japan	MURATA, TADAHIKO	H01L 21/92
*	0	JP 64002339 A	01-1989	Japan	HIRANO, YOSHIYUKI	H01L 21/92
*	Р	JP 05055228 A	03-1993	Japan	KADOTA, YASUO	H01L 21/321
*	Q	JP 04094131 A	03-1992	Japan	YAMASHITA et al.	H01L 21/321
*	R	JP 04030533 A	02-1992	Japan	OKANO, TAKASHI	H01L 21/321
*	S	JP 03191527 A	08-1991	Japan	KODA, TSUNEMITSU	H01L 21/321
*	Т	JP 03101233 A	04-1991	Japan	HASEGAWA, HITOSHI	H01L 21/321

NON-PATENT DOCUMENTS

*	l	
ļ	-	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	
٠		

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Applicant(s)/Patent Under Reexamination YU ET AL. 10/038,388 Notice of References Cited Examiner Art Unit Page 2 of 2 Alonzo Chambliss 2827

Application/Control No.

U.S. PATENT DOCUMENTS

	Deciment Number				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	E	US-			
_	F	US-			
	G	US-			
	Η	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 02125621 A	05-1990	Japan	MIYAMOTO, HIDENOBU	H01L 21/321
*	0	JP 01015956 A	01-1989	Japan	MORITA, TOSHIO	H01L 21/92
*	Р	JP 01012553 A	01-1989	Japan	OBARA, SHINJI	H01L 21/92
	Q					
	R					
	S					
	Т			· · · · · · · · · · · · · · · · · · ·		

NON-PATENT DOCUMENTS

*		Include an applicable A. M. Till Till Till Till Till Till Till Til
<u> </u>	<u> </u>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	Х	
*A co	of thi	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.